

June 2010

### **FDMC7664**

# N-Channel PowerTrench $^{\rm I\!R}$ MOSFET 30 V, 18.8 A, 4.2 m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 4.2 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 18.8 A
- Max  $r_{DS(on)}$  = 5.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 16.1 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- Termination is Lead-free and RoHS Compliant

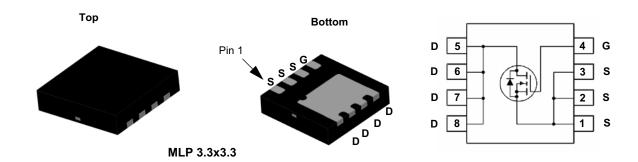


### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

### **Applications**

- DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook



### MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter	Parameter					
V <sub>DS</sub>	Drain to Source Voltage		30	V			
$V_{GS}$	Gate to Source Voltage	Gate to Source Voltage ±20					
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		24			
I <sub>D</sub>	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	18.8	Α		
	-Pulsed			60			
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)			188	mJ		
Б	Power Dissipation	T <sub>C</sub> = 25 °C		42	w		
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	2.3	VV		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C		

#### **Thermal Characteristics**

$R_{ heta JC}$	Thermal Resistance, Junction to Case	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 53	C/VV

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC7664	FDMC7664	MLP 3.3x3.3	13 "	12 mm	3000 units

### Electrical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

Symbol	Parameter	Parameter Test Conditions		Тур	Max	Units
Off Chara	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \text{ TMA}, V_{GS} = 0 \text{ V}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 ™A, referenced to 25 °C		12		mV/°C
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	тмД
IDSS	Zero Gate Voltage Drain Current	T <sub>J</sub> = 125 °C			250	
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA

#### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 ^{TM}\text{A}$	1.0	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 ™A, referenced to 25 °C		-7		mV/°C
	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 18.8 A		3.6	4.2	
r		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 16.1 A		4.5	5.5	mΩ
r <sub>DS(on)</sub> Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 18.8 A T <sub>J</sub> = 125 °C		4.4	5.4	11152	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 18.8 A		115		S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 45 V V 0 V	3655	4865	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V f = 1 MHz	1100	1465	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 WHZ	115	170	pF
R <sub>a</sub>	Gate Resistance		0.8	2.2	Ω

### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		15	27	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 18.8 A	7	14	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	37	59	ns
t <sub>f</sub>	Fall Time		6	12	ns
$Q_{g(TOT)}$	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	55	76	nC
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 4.5 V V <sub>DD</sub> = 15 V	25	34	nC
$Q_{gs}$	Gate to Source Charge	I <sub>D</sub> = 18.8 A	12		nC
Q <sub>ad</sub>	Gate to Drain "Miller" Charge		6		nC

### **Drain-Source Diode Characteristics**

V <sub>SD</sub> :	Source to Drain Dioge Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 18.8 \text{ A}$ (Note 2)		0.83	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2)		0.71	1.2	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 18.8 A, di/dt = 100 A/™s		41	65	ns
Q <sub>rr</sub>	Reverse Recovery Charge	IF = 18.8 A, di/dt = 100 A/ "S 20 3		35	nC	

#### NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $^{\text{\tiny TM}}\text{s},$  Duty cycle < 2.0 %.
- 3. E $_{AS}$  of 188 mJ is based on starting T $_{J}$  = 25 °C, L = 1 mH, I $_{AS}$  = 19.4 A, V $_{DD}$  = 27 V, V $_{GS}$  = 10 V.

### Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

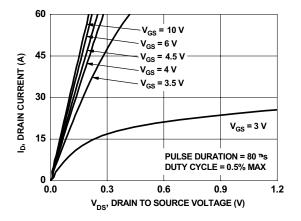


Figure 1. On Region Characteristics

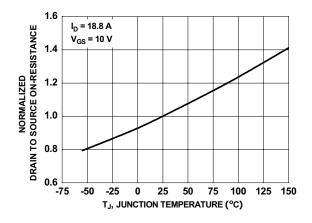


Figure 3. Normalized On Resistance vs Junction Temperature

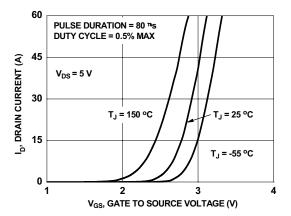


Figure 5. Transfer Characteristics

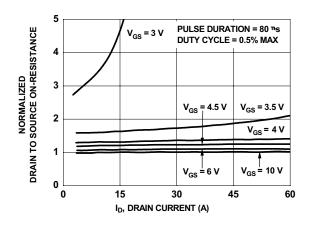


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

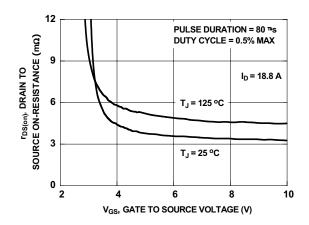


Figure 4. On-Resistance vs Gate to Source Voltage

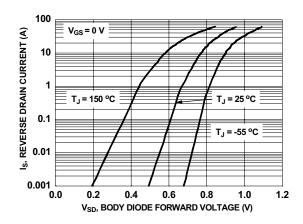


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

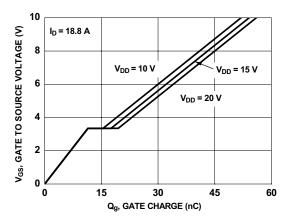


Figure 7. Gate Charge Characteristics

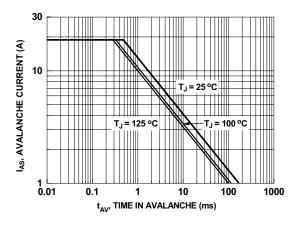


Figure 9. Unclamped Inductive Switching Capability

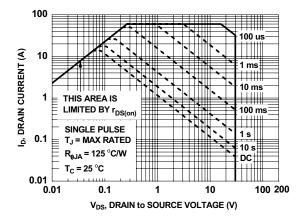


Figure 11. Forward Bias Safe Operating Area

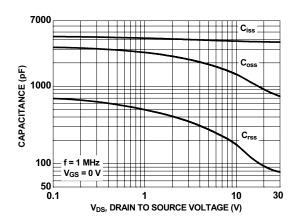


Figure 8. Capacitance vs Drain to Source Voltage

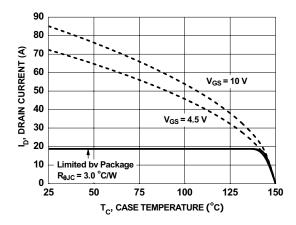


Figure 10. Maximum Continuous Drain Current vs Case Temperature

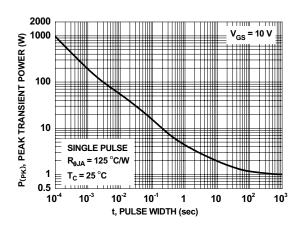


Figure 12. Single Pulse Maximum Power Dissipation

### Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

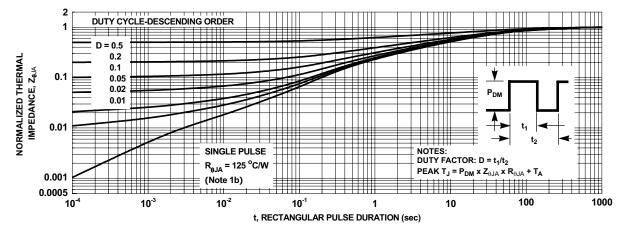
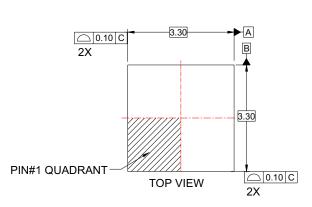
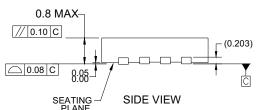
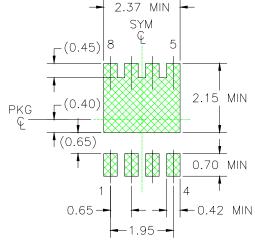


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

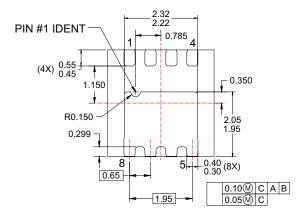
### **Dimensional Outline and Pad Layout**







RECOMMENDED LAND PATTERN



**BOTTOM VIEW** 

#### NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. DRAWING FILE NAME: MLP08SREVA
- E. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY





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Rev. 148